

## N-Channel Logic Level Enhancement Mode Field Effect Transistor

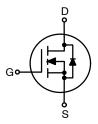
## BSS123L

#### Description

This N-channel enhancement mode field effect transistor is produced using high cell density, trench MOSFET technology. This product minimizes on-state resistance while providing rugged, reliable and fast switching performance. This product is particularly suited for low-voltage, low-current applications such as small servo motor control, power MOSFET gate drivers, logic level transistor, high speed line drivers, power management/power supply and switching applications.

#### **Features**

- 0.17 A, 100 V
  - $R_{DS(on)} = 6 \Omega @ V_{GS} = 10 V$
  - $R_{DS(on)} = 10 \Omega @ V_{GS} = 4.5 V$
- High Density Cell Design for Low R<sub>DS(ON)</sub>
- Rugged and Reliable
- Compact Industry Standard SOT-23 Surface Mount Package
- Very Low Capacitance
- Fast Switching Speed
- This Device is Pb-Free and Halogen Free

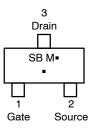


N-Channel



SOT-23-3 CASE 318-08

#### **MARKING DIAGRAM**



SB = Specific Device Code

M = Date Code\*

■ = Pb-Free Package

(Note: Microdot may be in either location)

\*Date Code orientation and/or position may vary depending upon manufacturing location.

#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
BSS123L	SOT-23-3	3000 /
	(Pb-Free)	Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

#### **BSS123L**

#### **ABSOLUTE MAXIMUM RATINGS** ( $T_A = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Value	Unit
$V_{DSS}$	Drain-Source Voltage	100	V
V <sub>GSS</sub>	Gate-Source Voltage	±20	V
I <sub>D</sub>	Maximum Drain Current – Continuous	0.17	Α
	Maximum Drain Current – Pulsed	0.68	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range	−55 to +150	°C
TL	Maximum Lead Temperature for Soldering Purposes, 1/16" from Case for 10 s	300	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

### **THERMAL CHARACTERISTICS** ( $T_A = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Value	Unit
PD	Maximum Power Dissipation (Note 1)	0.36	W
	Derate Above 25°C	2.8	mW/°C
$R_{ hetaJA}$	Thermal Resistance, Junction-to-Ambient (Note 1)	380	°C/W

#### ESD RATING (Note 2)

Symbol	Parameter	Value	Unit
HBM	Human Body Model per ANSI/ESDA/JEDEC JS-001-2012	50	V
CDM	Charged Device Model per JEDEC C101C	>2000	V

# ELECTRICAL CHARACTERISTICS (T<sub>A</sub> = 25°C unless otherwise noted) Symbol Parameter Test Cond

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
OFF CHARA	CTERISTICS					
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	100	103	-	V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250 μA, Referenced to 25°C	-	100	-	mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V	-	0.027	1	μΑ
		V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125°C	-	0.159	60	
		V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V	-	0.07	10	nA
I <sub>GSSF</sub>	Gate-Body Leakage, Forward	V <sub>GS</sub> = 20 V, V <sub>DS</sub> = 0 V	-	0.036	50	nA
I <sub>GSSR</sub>	Gate-Body Leakage, Reverse	V <sub>GS</sub> = -20 V, V <sub>DS</sub> = 0 V	-	-0.019	-50	nA
ON CHARAC	TERISTICS (Note 3)					
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}$ , $I_D = 1 \text{ mA}$	0.8	1.405	2	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	I <sub>D</sub> = 1 mA, Referenced to 25°C	-	-2.82	-	mV/°C
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 0.17 A	-	2.98	6	Ω
		$V_{GS} = 4.5 \text{ V}, I_D = 0.17 \text{ A}$	-	3.17	10	
		$V_{GS} = 10 \text{ V}, I_D = 0.17 \text{ A}, $ $T_J = 125^{\circ}\text{C}$	_	5.63	12	
I <sub>D(ON)</sub>	On-State Drain Current	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 5 V	0.680	0.735	-	Α
9FS	Forward Transconductance	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 0.17 A	0.08	2.13	-	S

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#### ELECTRICAL CHARACTERISTICS (T<sub>A</sub> = 25°C unless otherwise noted) (continued)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
DYNAMIC C	HARACTERISTICS					
C <sub>iss</sub>	Input Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$	-	21.5	-	рF
C <sub>oss</sub>	Output Capacitance	f = 1.0 MHz	-	3.52	-	
C <sub>rss</sub>	Reverse Transfer Capacitance		-	1.67	-	
$R_{G}$	Gate Resistance	V <sub>GS</sub> = 15 mV, f = 1.0 MHz	-	7.18	-	Ω
SWITCHING	CHARACTERISTICS (Note 3)					
t <sub>d(on)</sub>	Turn-On Delay	V <sub>DD</sub> = 30 V, I <sub>D</sub> = 0.28 A,	_	2.2	3.4	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ = 10 V, $R_{GEN}$ = 6 $\Omega$	=	1.7	18	
t <sub>d(off)</sub>	Turn-Off Delay		_	5.9	31	
t <sub>f</sub>	Turn-Off Fall Time		=	5.6	5	
Qg	Total Gate Charge	$V_{DS} = 30 \text{ V}, I_D = 0.22 \text{ A},$	-	0.793	2.5	nC
Q <sub>gs</sub>	Gate-Source Charge	V <sub>GS</sub> = 10 V	=	0.092	-	
$Q_{gd}$	Gate-Drain Charge		_	0.171	-	
DRAIN-SOU	RCE DIODE CHARACTERISTICS AND MA	AXIMUM RATINGS				
V <sub>SD</sub>	Drain-Source Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 440 mA (Note 1)	-	0.867	1.3	V
T <sub>rr</sub>	Diode Reverse Recovery Time	$I_F = 0.2 \text{ A, } d_{if}/d_t = 100 \text{ A/}\mu\text{s}$	_	11.9	-	ns
Q <sub>rr</sub>	Diode Reverse Recovery Charge		_	1.3	_	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

1.  $R_{\theta JA}$  is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design. a) 380°C/W when mounted on a minimum pad.



2. ESD values are in typical, no over–voltage rating is implied, ESD CDM zap voltage is 2000 V maximum. 3. Pulse test: pulse width  $\leq$  300 ms, duty cycle  $\leq$  2.0%.

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#### **TYPICAL CHARACTERISTICS**

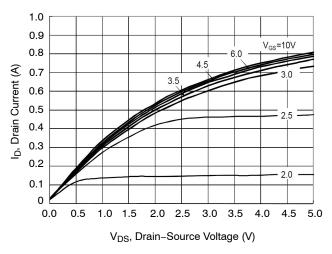


Figure 1. On-Region Characteristics

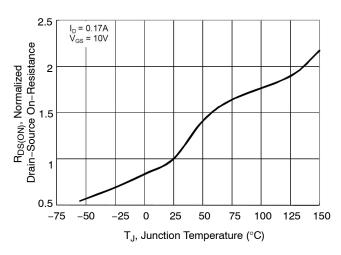


Figure 3. On-Resistance Variation with Temperature

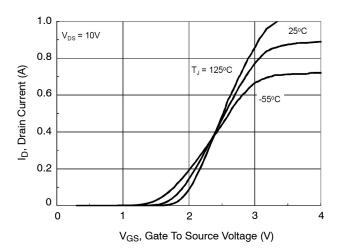


Figure 5. Transfer Characteristics

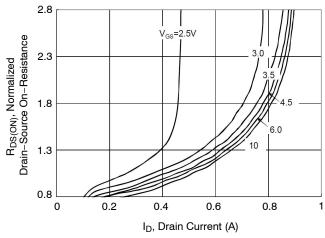


Figure 2. On-Resistance Variation with Gate Voltage and Drain Current

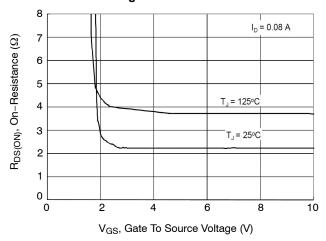


Figure 4. On-Resistance Variation with Gate-to-Source Voltage

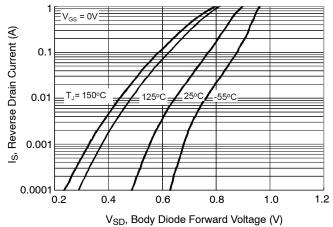
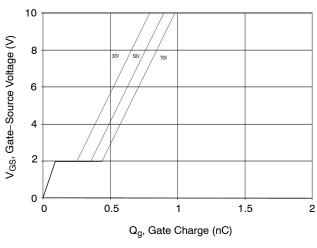


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature

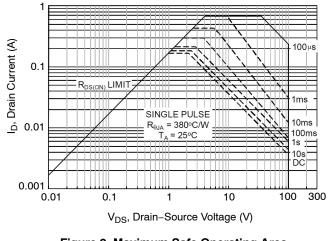
#### TYPICAL CHARACTERISTICS (continued)



 $\begin{array}{c} 100 \\ \hline \\ Old \\ Old \\ Old \\ Old \\ \hline \\ Old \\ O$ 

Figure 7. Gate Charge Characteristics

Figure 8. Capacitance Characteristics



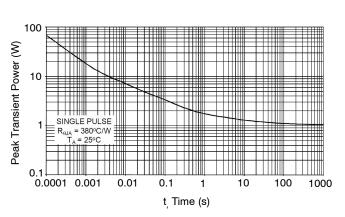


Figure 9. Maximum Safe Operating Area

Figure 10. Single Pulse Maximum Power Dissipation

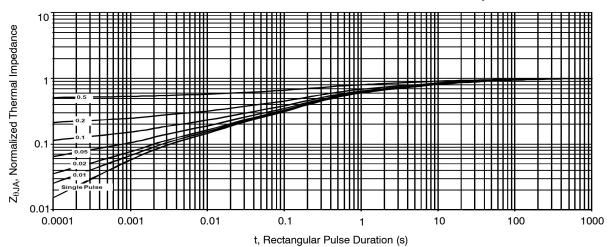


Figure 11. Transient Thermal Response Curve

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